Surface morphology of InAs considering entropy effects

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Computational Materials Design

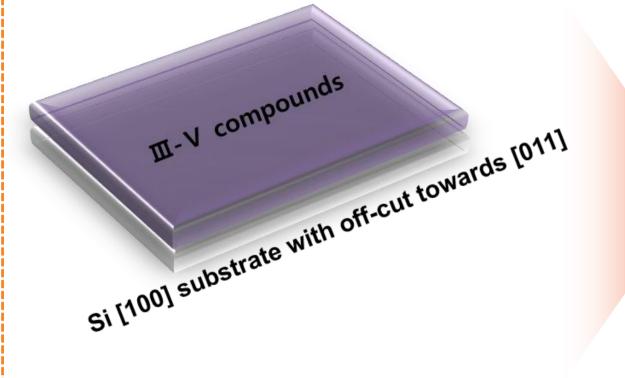


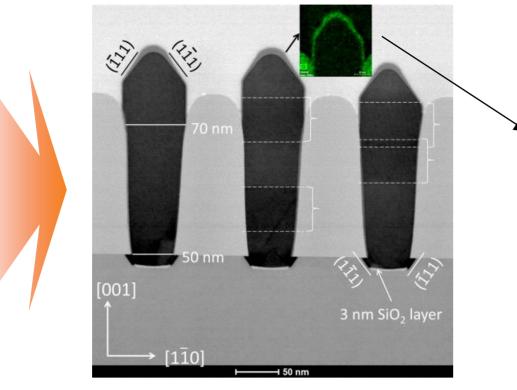
• COPMUTATIONAL DETAILS

Computational details

- VASP (Vienna *ab-initio* Simulation Package)
- xc-functional : LDA-CA
- Cutoff energy : 300 eV
- k-points : G $8 \times 8 \times 8$ for the conventional cell of InAs.
- Valence treatment : As=4s²4p³, In=4d¹⁰5s²5p¹
- Vacuum thickness : >10 Å

III-V compounds on Si [100] substrate





GaAs islands at 550 °C

compounds are required to be grown on Si Ш-V

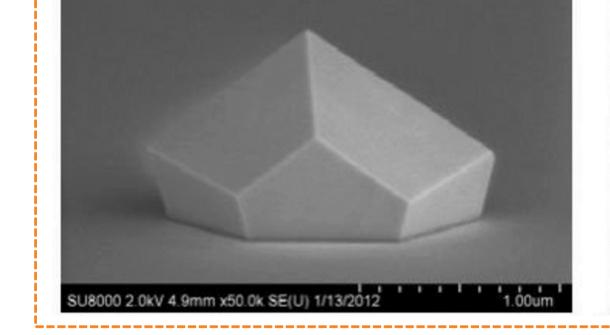
How can we

predict the

surface structures

and

morphology?



GaAs islands at 575 °C

Appl. Phys. Lett. 102, 191915 (2013). Acc.V Spot Magn Det WD |-10.0 kV 2.0 20000∞ TLD 5.0

[100] substrate.

7 (1-10) facet

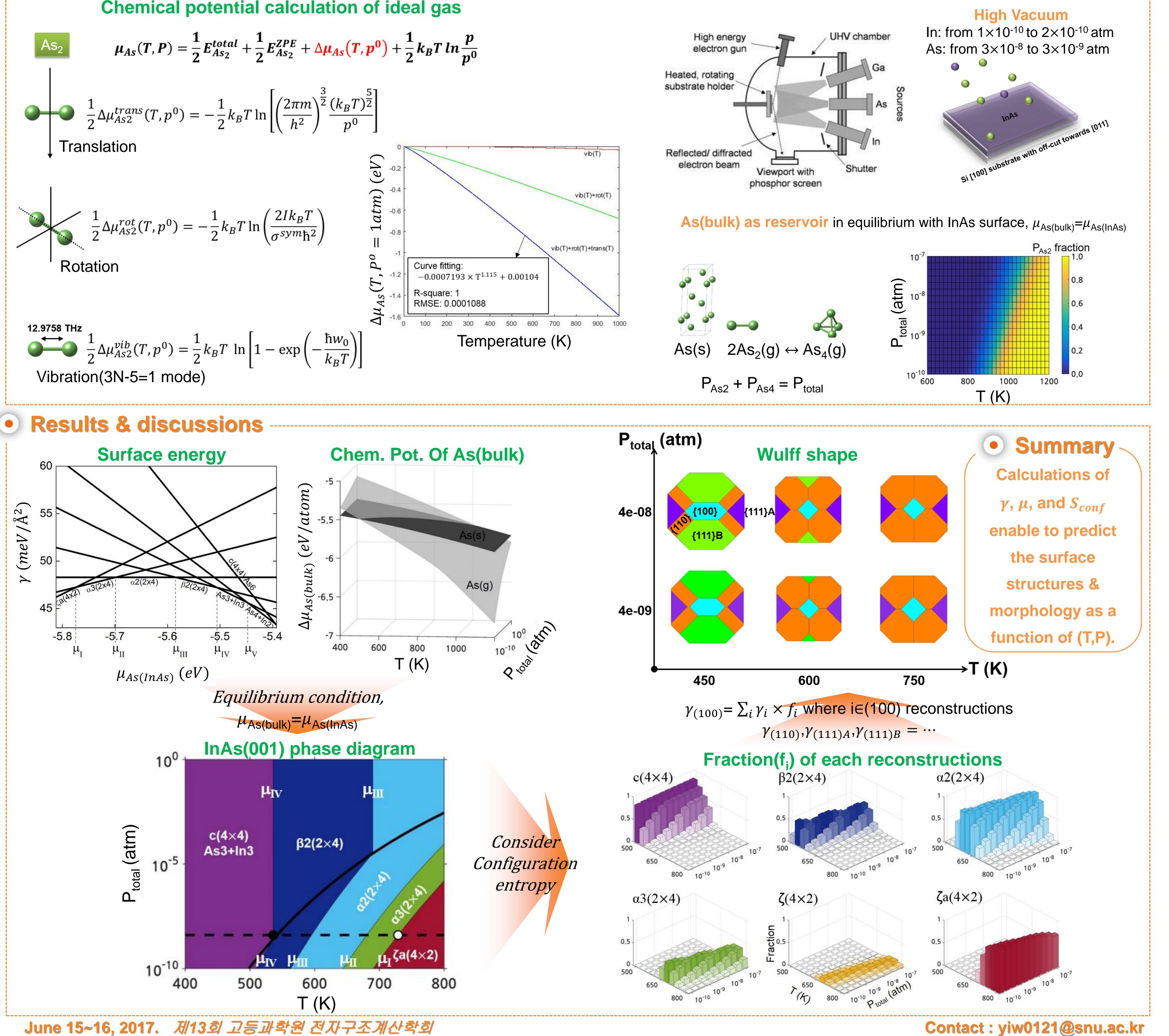
(113)_A facet

(111)_A facet

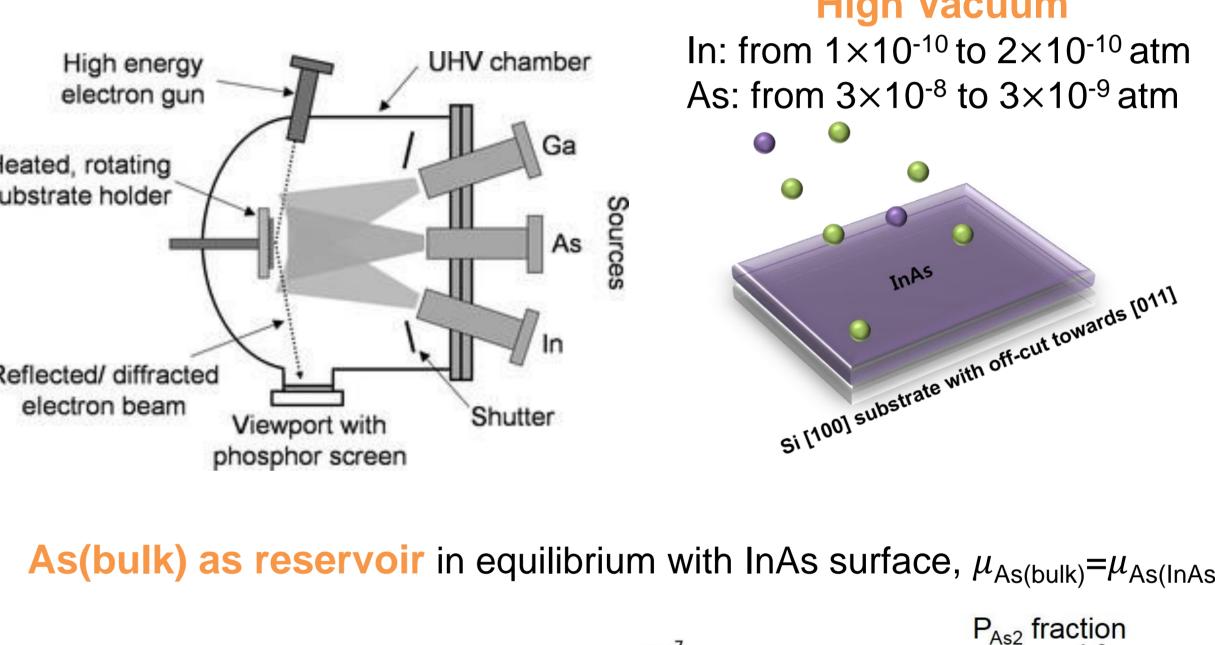
(001) tace

- The morphology is composed of some facets ulletwith different orientations.
- The surface morphology depends on the environment conditions (T, P).
- The top 5 layers of the total 9 layers were allowed to move.
- The bottom layers were fixed and saturated with hydrogen.

METHODOLOG



Arsenic as reservoir in Molecular Beam Epitaxy chamber



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